

April 2013

## FDP20N50 / FDPF20N50 / FDPF20N50T

# N-Channel UniFET<sup>TM</sup> MOSFET

500 V, 20 A, 230 m $\Omega$ 

#### **Features**

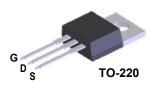
- $R_{DS(on)}$  = 230 m $\Omega$  (Typ.) @  $V_{GS}$  = 10 V,  $I_D$  = 10 A
- Low Gate Charge (Typ. 45.6 nC)
- Low C<sub>rss</sub> (Typ. 27 pF)
- 100% Avalanche Tested

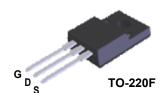
## **Applications**

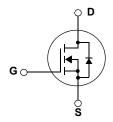
- LCD/LED/PDP TV
- Lighting
- · Uninterruptible Power Supply
- AC-DC Power Supply

## **Description**

UniFET<sup>TM</sup> MOSFET is Fairchild Semiconductor<sup>®</sup>, s high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.







## **Absolute Maximum Ratings**

Symbol	Parameter		FDP20N50	FDPF20N50 / FDPF20N50T	Unit	
V <sub>DSS</sub>	Drain-Source Voltage			V		
I <sub>D</sub>	Drain Current	- Continuous (T <sub>C</sub> = 25°C) - Continuous (T <sub>C</sub> = 100°C)		20 12.9	20 * 12.9 *	A A
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	80	80 *	Α
V <sub>GSS</sub>	Gate-Source voltage		±30		V	
E <sub>AS</sub>	Single Pulsed Avalanche Energy		(Note 2)	1110		mJ
I <sub>AR</sub>	Avalanche Current		(Note 1)	20		Α
E <sub>AR</sub>	Repetitive Avalanche Energy		(Note 1)	25		mJ
dv/dt	Peak Diode Recovery dv/dt (N		(Note 3)	4.5		V/ns
$P_{D}$	Power Dissipation	(T <sub>C</sub> = 25°C) - Derate above 25°C		250 2.0	38.5 0.3	W W/°C
T <sub>J,</sub> T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150		°C	
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300			

<sup>\*</sup> Drain current limited by maximum junction temperature

#### **Thermal Characteristics**

Symbol	Parameter	FDP20N50	FDPF20N50 / FDPF20N50T	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	0.5	3.3	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink, Typ.	0.5		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	62.5	62.5	°C/W

# **Package Marking and Ordering Information**

<b>Device Marking</b>	Device	Package	Reel Size	Tape Width	Quantity
FDP20N50	FDP20N50	TO-220	-	-	50
FDPF20N50	FDPF20N50	TO-220F	-	-	50
FDPF20N50T	FDPF20N50T	TO-220F	-	-	50

## **Electrical Characteristics** $T_C = 25$ °C unless otherwise noted

Symbol	Parameter	Conditions	Min.	Тур.	Max	Unit
Off Charac	teristics	•		•		•
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage $V_{GS} = 0V$ , $I_D = 250\mu A$		500			V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient $I_D = 250\mu A$ , Referenced to 25°C			0.5		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 500V, V_{GS} = 0V$ $V_{DS} = 400V, T_{C} = 125^{\circ}C$			1 10	μ <b>Α</b> μ <b>Α</b>
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30V, V <sub>DS</sub> = 0V			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30V, V <sub>DS</sub> = 0V			-100	nA
On Charac	teristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{00} = 10V I_{0} = 10A$		0.20	0.23	Ω
9 <sub>FS</sub>	Forward Transconductance $V_{DS} = 40V, I_D = 10A$			24.6		S
Dynamic C	haracteristics	•		•	•	·
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V,		2400	3120	pF
C <sub>oss</sub>	Output Capacitance	f = 1.0MHz	-	355	465	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		-	27		pF
	Characteristics	•				•
t <sub>d(on)</sub>	Turn-On Delay Time $V_{DD} = 250V, I_D = 20A$			95	200	ns
t <sub>r</sub>	Turn-On Rise Time	$R_G = 25\Omega$		375	760	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			100	210	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4)		105	220	ns
$Q_g$	Total Gate Charge	V <sub>DS</sub> = 400V, I <sub>D</sub> = 20A		45.6	59.5	nC
$Q_{gs}$	Gate-Source Charge	V <sub>GS</sub> = 10V		14.8		nC
$Q_{gd}$	Gate-Drain Charge	(Note 4)		21.6		nC
Drain-Sour	rce Diode Characteristics and Maximur	n Ratings				
I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current				20	Α
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current				80	Α
$V_{SD}$	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = 20A			1.4	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>S</sub> = 20A		507		ns
Q <sub>rr</sub>	Reverse Recovery Charge	dl <sub>F</sub> /dt =100A/μs		7.20		μС

#### NOTES:

<sup>1.</sup> Repetitive Rating: Pulse width limited by maximum junction temperature

<sup>2.</sup> L = 5.0mH,  $I_{AS}$  = 20A,  $V_{DD}$  = 50V,  $R_{G}$  = 25 $\Omega$ , Starting  $T_{J}$  = 25 $^{\circ}$ C

<sup>3.</sup>  $I_{SD} \le 20 A$ , di/dt  $\le 200 A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J$  = 25°C

<sup>4.</sup> Essentially Independent of Operating Temperature Typical Characteristics

## **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

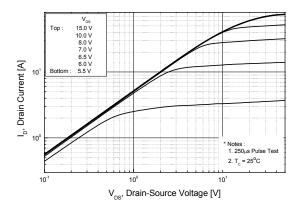


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

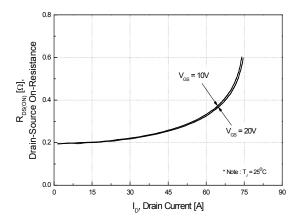


Figure 5. Capacitance Characteristics

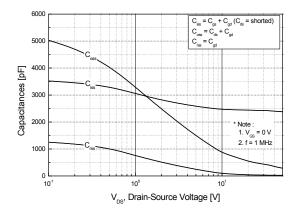


Figure 2. Transfer Characteristics

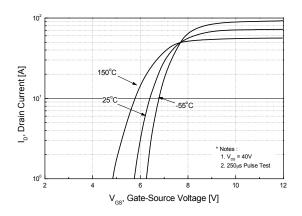
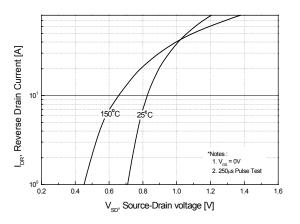
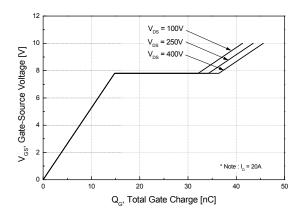


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue



**Figure 6. Gate Charge Characteristics** 



## Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

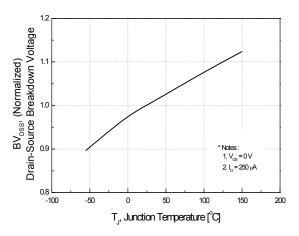


Figure 8. On-Resistance Variation vs. Temperature

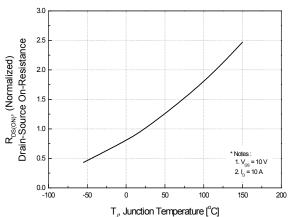
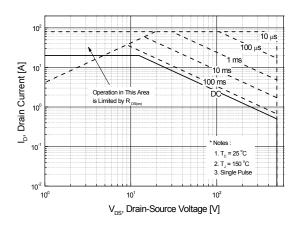


Figure 9-1. Maximum Safe Operating Area - FDP20N50

Figure 9-2. Maximum Safe Operating Area - FDPF20N50



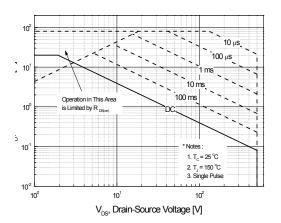
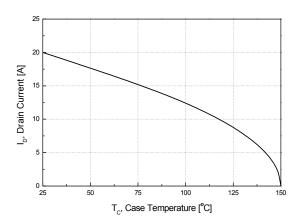


Figure 10. Maximum Drain Currentvs. Case Temperature



## **Typical Performance Characteristics** (Continued)

Figure 11-1. Transient Thermal Response Curve - FDP20N50

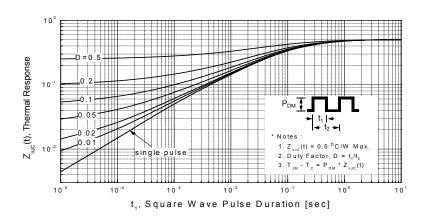
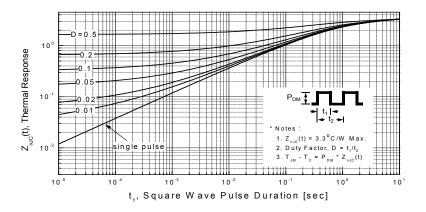
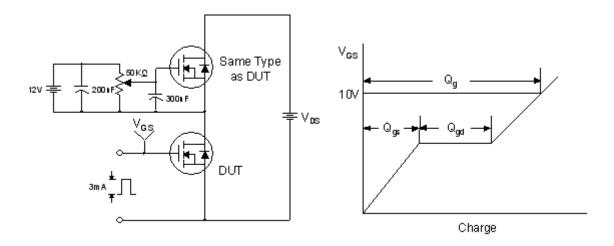


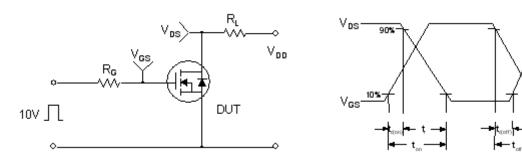
Figure 11-2. Transient Thermal Response Curve - FDPF20N50



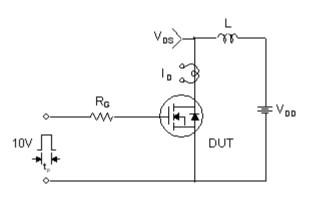
### **Gate Charge Test Circuit & Waveform**

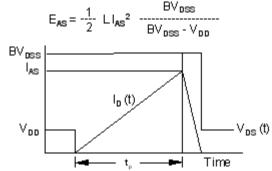


### **Resistive Switching Test Circuit & Waveforms**

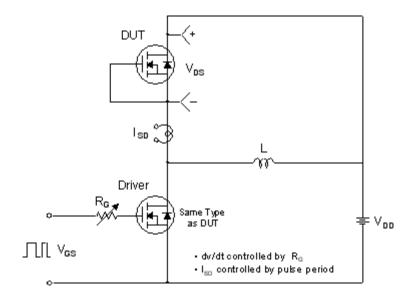


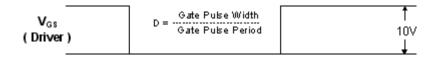
## **Unclamped Inductive Switching Test Circuit & Waveforms**

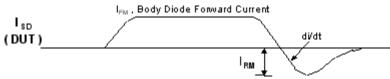




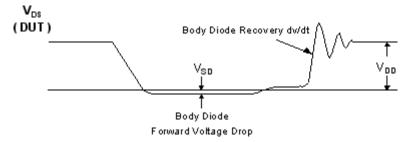
#### Peak Diode Recovery dv/dt Test Circuit & Waveforms





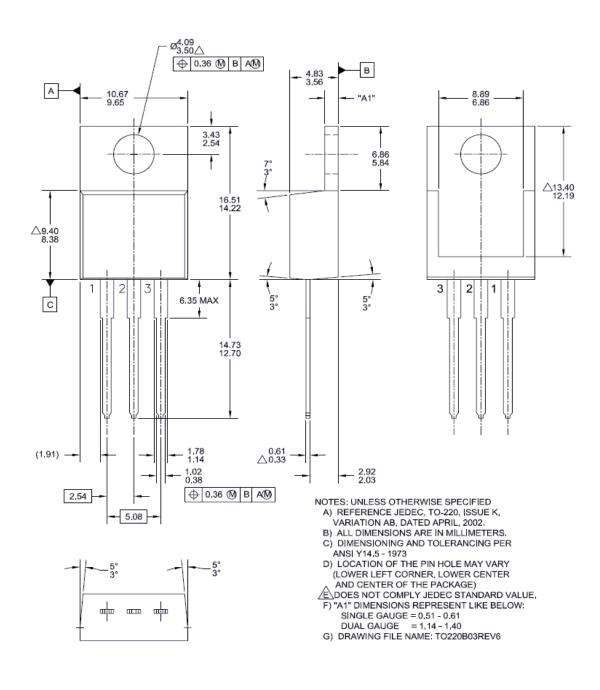


Body Diode Reverse Current



## **Mechanical Dimensions**

# TO-220B03



Dimensions in Millimeters

## **Mechanical Dimensions** TO-220M03 2.742.34 10.36 Α 9.96 Ø<sup>3.28</sup> 7.00 3.40 3.08 0.70 3.20 SEE NOTE "F" SEE NOTE "F" 6.88 6.48 (+)1 X 45° 16.07 15.67 16.00 15.60 (3.23) B 3 1.47 2.96 1.24 2.14 2.56 0.90 10.05 0.70 9.45 $\oplus$ 0.50 M A 30° 0.45 0.60 0.25 0.45 2.54 2.54 NOTES: A. EXCEPT WHERE NOTED CONFORMS TO EIAJ SC91A B) DOES NOT COMPLY EIAJ STD. VALUE. C. ALL DIMENSIONS ARE IN MILLIMETERS. D. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS. 4.90 <u>/в</u>` 4.50 E. DIMENSION AND TOLERANCE AS PER ASME Y14.5-1994 F. OPTION 1 - WITH SUPPORT PIN HOLE. OPTION 2 - NO SUPPORT PIN HOLE. G. DRAWING FILE NAME: TO220M03REV3 **Dimensions in Millimeters**





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